

<b>Notice of References Cited</b>	Application/Control No. 10/782,619	Applicant(s)/Patent Under Reexamination HUTNIK ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0049842	04-2002	Huetsch et al.	709/225
*	B	US-2003/0115258	06-2003	Baumeister et al.	709/203
*	C	US-2004/0047287	03-2004	Tremblay et al.	370/229
*	D	US-2004/0264465	12-2004	Dunk, Craig A.	370/392
*	E	US-2005/0055374	03-2005	Sato, Naoyuki	707/104.1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1302869 A1	04-2003	EPO	Brescia	G06F 17/30
	O	EP 1180873 A2	02-2002	EPO	McCann	H04L 12/29
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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